

<b>Notice of References Cited</b>		Application/Control No. 10/606,981	Applicant(s)/Patent Under Reexamination VAISHYA ET AL.	
		Examiner DEVONA E. FAULK	Art Unit 2615	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,146,505	09-1992	Pfaff et al.	381/71.9
*	B	US-2002/0097884	07-2002	Cairns, Douglas A.	381/71.4
*	C	US-5,434,925	07-1995	Nadim, Mohammed	381/71.12
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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